

image

2829



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE  
(Case No. 219.002-US)

the Application of: **Yamada et al.**

Serial No: **09/702,831**

Filed: **November 1, 2000**

Title: **Semiconductor Device Tester**

) Group  
) Art Unit: **2829**  
)  
) Before  
) Examiner: **V. Nguyen**  
)

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail with sufficient postage in an envelope addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on March 15, 2004  
Date  
Michiko Sites  
(person signing this certificate)  
Michiko Sites  
Signature

INFORMATION DISCLOSURE STATEMENT

Dear Sir:

Submitted herewith are two (2) sheets of a modified Form PTO-1449. A copy of each document cited on the attached Form PTO-1449 is also submitted.

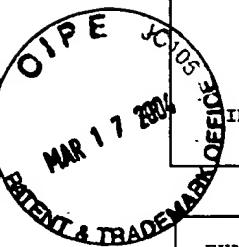
Notably, the documents listed on the attached Form PTO-1449 were identified and/or cited in applications (namely, U.S. App. Serial Nos. 09/451,440 and 09/865,528) that include subject matter which is similar to that in the above-reference application.

It is respectfully requested that the Examiner make his/her consideration of these documents formally of record with the initial Office Action.

Respectfully submitted,

Date: March 15, 2004

Neil A. Steinberg, Reg. No. 34,735  
650-968-8079



PTO-1449 (Modified)  U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  INFORMATION DISCLOSURE STATEMENT BY APPLICANT	ATTY. DOCKET NO.	SERIAL NUMBER
	219.002-US	09/702,831
	APPLICANT(S)	
	Yamada et al.	
	FILING DATE	GROUP ART UNIT
	November 1, 2000	2829

## U.S. PATENT DOCUMENTS

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE
	4,949,162	8/1990	Tamaki et al.			
	4,988,877	1/1991	Stokowski et al.			
	5,001,536	3/1991	Fukuzawa et al.			
	5,327,012	7/1994	Yano et al.			
	5,412,210	5/1995	Todokoro et al.			
	5,637,186	6/1997	Liu et al.			
	5,780,870	7/1998	Maeda et al.			

## FOREIGN PATENT DOCUMENTS

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION YES/NO
	6-273297	9/1994	Japan			
	7-66172	3/1995	Japan			
	57-6310	1/1996	Japan			
	8-313244	11/1996	Japan			
	9-61142	3/1997	Japan			
	10-300450	11/1998	Japan			
	50-63990	5/1975	Japan			
	62-19707	1/1987	Japan			
	8-5528	1/1996	Japan			

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)


EXAMINER	DATE CONSIDERED
EXAMINER: Initial citation if reference was considered. Draw line through citation if not in conformance to MPEP 609 and not considered. Include copy of this form with next communication to applicant.	

<b>PTO-1449 (Modified)</b>  <b>U.S. DEPARTMENT OF COMMERCE</b> <b>PATENT AND TRADEMARK OFFICE</b>  <b>INFORMATION DISCLOSURE STATEMENT</b> <b>BY APPLICANT</b>	<b>ATTY. DOCKET NO.</b> <b>219.002-US</b>	<b>SERIAL NUMBER</b> <b>09/702,831</b>
	<b>APPLICANT(S)</b> <b>Yamada et al.</b>	
	<b>FILING DATE</b> <b>November 1, 2000</b>	<b>GROUP ART UNIT</b> <b>2829</b>

## U.S. PATENT DOCUMENTS

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE
	5,900,645	5/1999	Yamada			
	6,037,588	3/2000	Liu et al.			
	6,127,193	10/2000	Bang et al.			
	6,317,514	11/2001	Reinhorn et al.			
	3,614,608	10/1971	Giedd et al.			
	5,365,034	11/1994	Kawamura et al.			
	5,453,994	9/1995	Kawamoto et al.			
	5,493,236	2/1996	Ishii et al.			
	5,757,198	5/1998	Shida et al.			
	5,815,002	9/1998	Nikawa			
	6,294,919	9/2001	Baumgart			

## FOREIGN PATENT DOCUMENTS

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION YES/NO	
	10-281746	10/1998	Japan				

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)


<b>EXAMINER</b>	<b>DATE CONSIDERED</b>
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